

**PATENT APPLICATION**  
**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

In re application of

Satoshi HANADA, et al.

Appln. No.:

Confirmation No.: Unknown

Group Art Unit: Unknown

Filed: November 27, 2001

Examiner: Unassigned

For: FOAMED POLYOLEFIN RESIN SHEET

**PRELIMINARY AMENDMENT**

Commissioner for Patents  
Washington, D.C. 20231

Sir:

Prior to examination, please amend the above-identified application as follows:

**IN THE SPECIFICATION:**

Page 4, paragraph bridging pages 4-5:

A<sup>1</sup>

In the present invention the infrared absorption spectrum of a sample is measured according to the following process. First, the sample is subjected to hot pressing at a temperature about 30 to 50°C higher than the melting point of a major component resin contained in the sample (for example about 200°C if the major component resin is a polypropylene resin) for three minutes and then subjected to cold pressing at 30°C for five minutes, to form a film having a thickness of 30 to 80 μm. The film thus obtained is loaded on an infrared spectrometer (for example FT-IR spectrometer Model 1600 manufactured by PERKIN ELMER CO., LTD.) for measurement of its infrared absorption spectrum.